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Yutaka Shi Masahiko M Isao Nakan ** CONTINUING I ** FOREIGN APP JAPAN 200	inagaw Kimura Mura, I DATA PLICAT 01-125	TIONS ************************************	m ye,	sanc					
D3 V3C [18 (a-d) conditions   D1   1   1					DRA	EETS TOTAL AWING CLAIMS 29 23		INDEPENDENT CLAIMS 5	
Miles & Stockbridg Suite 500 1751 Pinnacle Driv McLean ,VA 2210 TITLE	ge P.C ive 02								
Semiconductor integrated circuit and a method of testing the same									
RECEIVED N	FEES: Authority has been given in Paper No to charge/credit DEPOSIT ACCOUNT No for following:				All Fees  1.16 Fees (Filing)  1.17 Fees (Processing Ext. of time)  1.18 Fees (Issue)  Other  Credit				